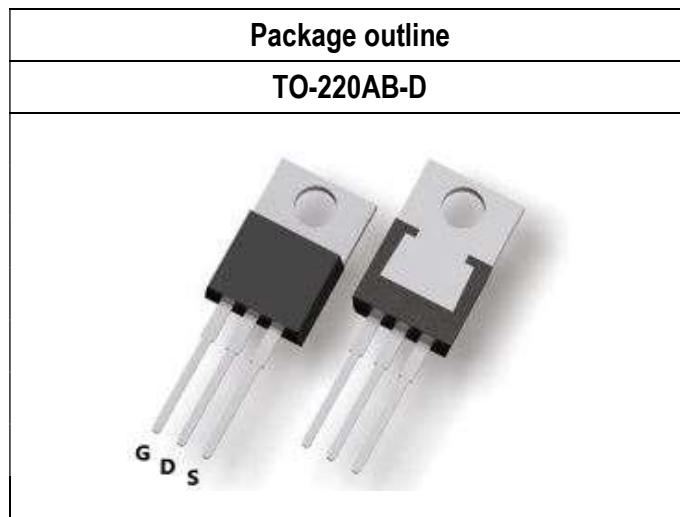


Key parameter	N channel	Unit
V <sub>DSS</sub>	90	V
R <sub>DSON</sub> (ON) max. V <sub>GS</sub> =10V	3.9	mΩ
I <sub>D</sub>	178	A
V <sub>GS(TH) Typ.</sub>	3.0	V
C <sub>iss</sub> Typ.	6525	pF
Q <sub>g10V</sub> Typ.	116.6	nC
E <sub>AS</sub>	88.2	mJ



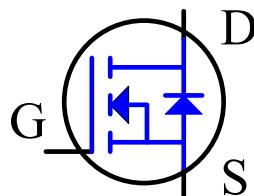
### Description

The DG100N02PBC used double-gate structure of MOSFET to provide excellent electrical parameter. There is high speed switching capability, low R<sub>DSON</sub> resistance, stabilizing qualities and characteristics for these devices. Moreover, it has had extreme high cell density in design. These features combine to be an advantage design for use in wide variety of application including small signal control and load switch application.

### Features

- ◇ Low On-Resistance RDS (on)
- ◇ Low Input Capacitance
- ◇ Low Gate Charge
- ◇ Fully Characterized Capacitance and Avalanche
- ◇ Pb-free lead plating; RoHS compliant

### Symbol and Pin assignment



### Potential application

- DC-DC converter
- Load Switch Application
- Motor Driving Application
- Switch Mode Power Supply

### Order Information

Item	Description
1. Order Code	DG100N02PBC
2. Part Number	DG100N02PBC
3. Package Type	TO-220AB-D
4. Package Code	PB
5. Packing Type	Tube
6. Quantity in Pack	50
7. RoHS Status	Halogen-Free

**Content**

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**1. Absolute Maximum Ratings (T<sub>J</sub>=25°C unless otherwise noted)**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	90	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Drain Current-Continuous <sup>Note 1</sup>	T <sub>C</sub> =25°C	178	A
	T <sub>C</sub> =100°C	113	A
Drain Current-Continuous <sup>Note 2</sup>	T <sub>A</sub> =25°C	18.7	A
	T <sub>A</sub> =70°C	10	A
Drain Current-Pulsed <sup>Note 3</sup>	I <sub>DM</sub>	400	A
Avalanche Current	I <sub>AR</sub>	42	A
Single Pulse Avalanche Energy <sup>Note 4</sup>	E <sub>AS</sub>	88.2	mJ
Maximum Power Dissipation	T <sub>C</sub> =25°C	219	W
	T <sub>C</sub> =100°C	87.7	W
	T <sub>A</sub> =25°C	2.4	W
	T <sub>A</sub> =70°C	1.5	W
	Derate Factor Above T <sub>C</sub> =25°C	0.4	W/°C
Max. Operating Junction Temperature	T <sub>J</sub>	150	°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

**2. Thermal Resistance Ratings**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Thermal resistance, Junction-Case	R <sub>θJC-N</sub>	Please refer to Note 5	-	-	0.57	°C/W
Thermal resistance, Junction-Ambient	R <sub>θJA-N</sub>	Please refer to Note 5	-	-	51.82	°C/W

**Notes:**

1. Limited by silicon chip capability and R<sub>θJC-N</sub> junction-to-case thermal resistance.
2. The maximum current rating is limited by package and R<sub>θJA-N</sub> junction-to-ambient thermal resistance.
3. Must be ensure junction temperature does not exceed 150-degree C. (Pulse Width≤100uS, Duty≤2%)
4. Limited by T<sub>Jmax</sub>, starting T<sub>J</sub>=25°C, L=0.1mH, R<sub>g</sub>=25Ω, I<sub>D</sub>=42A, V<sub>GS</sub>=10V.
5. The value of thermal resistance is measured with the single device put on cooling plate under a still air environment temperature is 25 degree C based on JEDEC standard JESD51-14 and JESD51-2a. Thermal resistance obtained depends on the user's specific board design and given application.

**3. Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

STATIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	90	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =90V, V <sub>GS</sub> =0V	-	-	1	μA
		V <sub>DS</sub> =90V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	-	-	100	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> =+20/-14V, V <sub>DS</sub> =0V	-	-	±100	nA

STATIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	2.8	3.0	3.3	V
Drain-Source On-State Resistance	R <sub>D(S)ON</sub>	V <sub>GS</sub> =10V, I <sub>DS</sub> =50A	-	3.6	3.9	mΩ
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	-	0.8	-	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =5V, I <sub>DS</sub> =20A	-	40	-	S

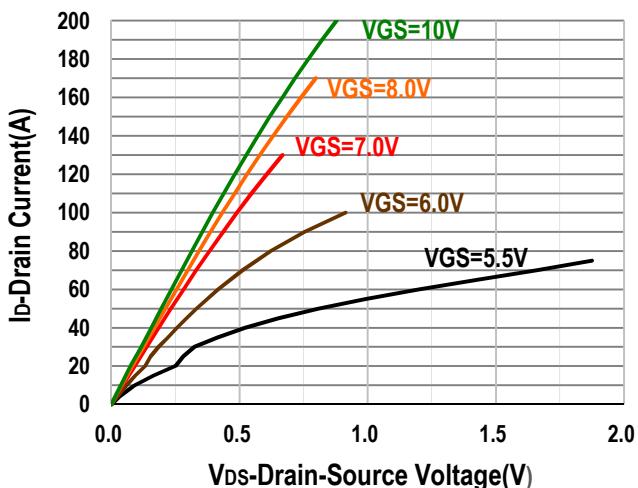
DYNAMIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C <sub>iss</sub>	V <sub>DD</sub> =90V, V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz	-	6525	-	pF
Output Capacitance	C <sub>oss</sub>	V <sub>DD</sub> =90V, V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz	-	725.5	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	V <sub>DD</sub> =90V, V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1MHz	-	31.5	-	pF
Turn-On Delay Time	T <sub>d(on)</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>DS</sub> =50A, R <sub>GEN</sub> =2.4Ω	-	22.8	-	nS
Rise Time	T <sub>r</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>DS</sub> =50A, R <sub>GEN</sub> =2.4Ω	-	90.3	-	nS
Turn-Off Delay Time	T <sub>d(off)</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>DS</sub> =50A, R <sub>GEN</sub> =2.4Ω	-	55.3	-	nS
Fall Time	T <sub>f</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>DS</sub> =50A, R <sub>GEN</sub> =2.4Ω	-	92.7	-	nS

GATE CHARGE CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Gate to Source Gate Charge	Q <sub>gs</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	33.6	-	nC
Gate charge at threshold	Q <sub>g(th)</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	20.4	-	nC
Gate to Drain Charge	Q <sub>gd</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	40	-	nC
Switching charge	Q <sub>SW</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	53.3	-	nC
Gate charge total	Q <sub>g 10V</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	116.6	-	nC
Gate plateau voltage	V <sub>plateau</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =50A, V <sub>GS</sub> =0 to 10V	-	5.2	-	V
Gate charge total, sync. FET (Q <sub>g</sub> - Q <sub>gd</sub> )	Q <sub>g(sync)</sub>	V <sub>DS</sub> =0.1V, V <sub>GS</sub> =0 to 10V	-	76.6	-	nC

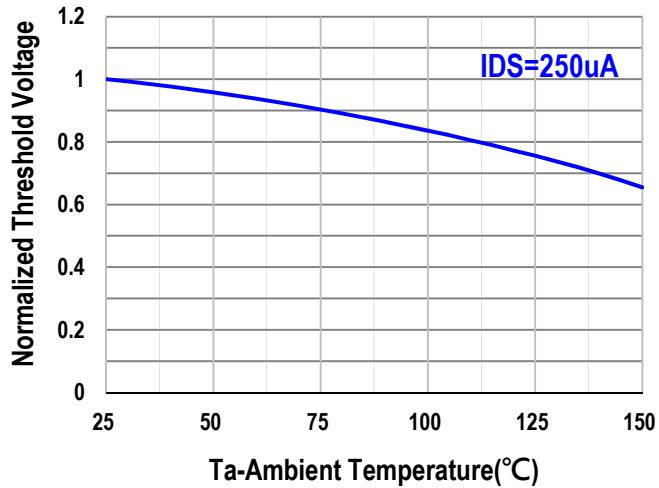
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Body Diode continuous forward current	I <sub>s</sub>	T <sub>C</sub> =25°C	-	178	-	A
Body Diode pulse current	I <sub>SM</sub>	T <sub>C</sub> =25°C	-	-	200	A
Body Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>s</sub> =50A	-	0.89	1.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=100A/μs	-	65.9	-	nS
		V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=200A/μs	-	59.5	-	nC
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=100A/μs	-	71.6	-	nS
		V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=200A/μs	-	122.1	-	nC
Body Diode Reverse Recovery Current	I <sub>rm</sub>	V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=100A/μs	-	2.1	-	A
		V <sub>DD</sub> =50V, I <sub>F</sub> =50A, di/dt=200A/μs	-	3.8	-	A

#### 4. Typical Operating Characteristics Diagram

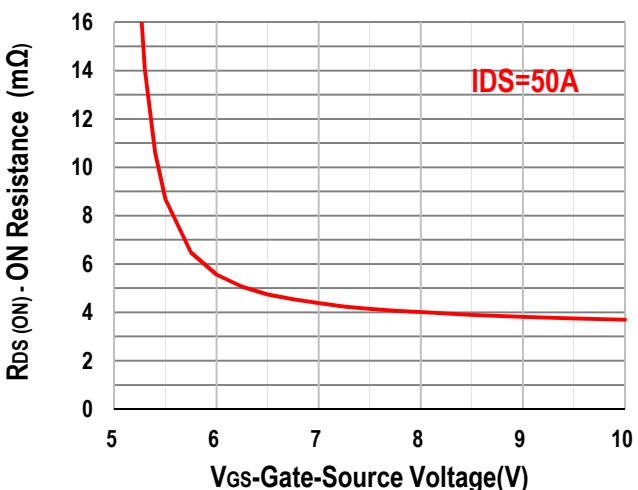
**Fig. 1: Output Characteristics**



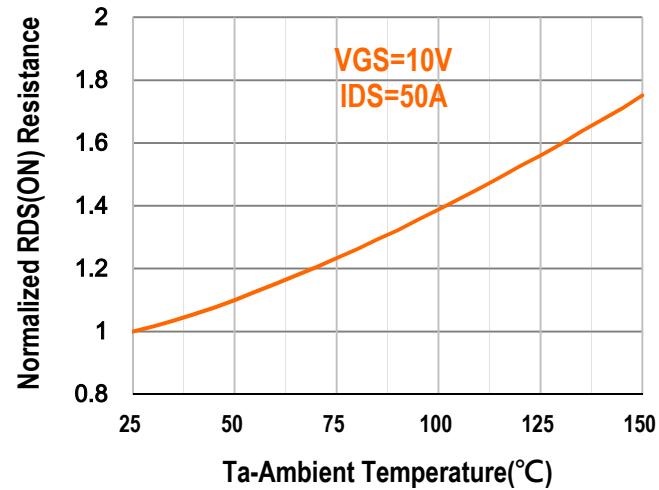
**Fig. 2: Normalized  $V_{(TH)GS}$  Voltage Vs.  $T_A$**



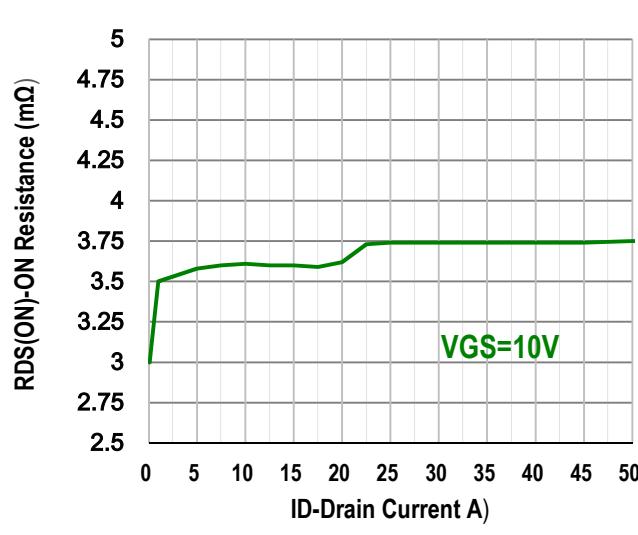
**Fig. 3: Drain-Source On Resistance Vs Vgs**



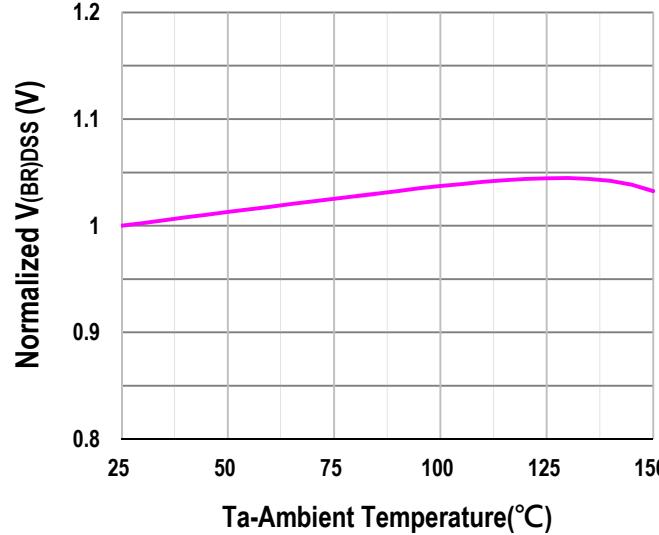
**Fig. 4: Normalized  $R_{DS(ON)}$  Resistance Vs.  $T_A$**



**Fig. 5: Drain-Source On Resistance Vs Id**

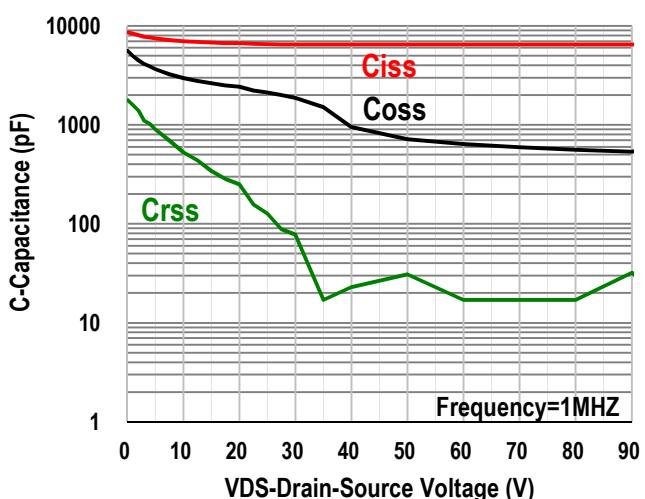


**Fig. 6: Normalized  $BV_{DSS}$  Voltage Vs  $T_A$**

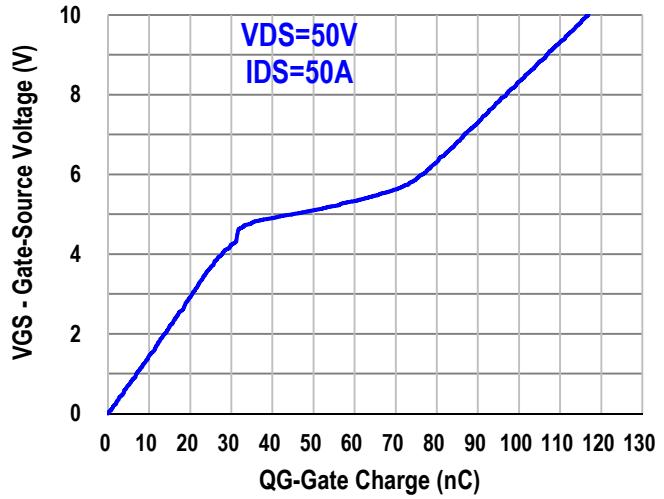


#### 4. Typical Operating Characteristics Diagram

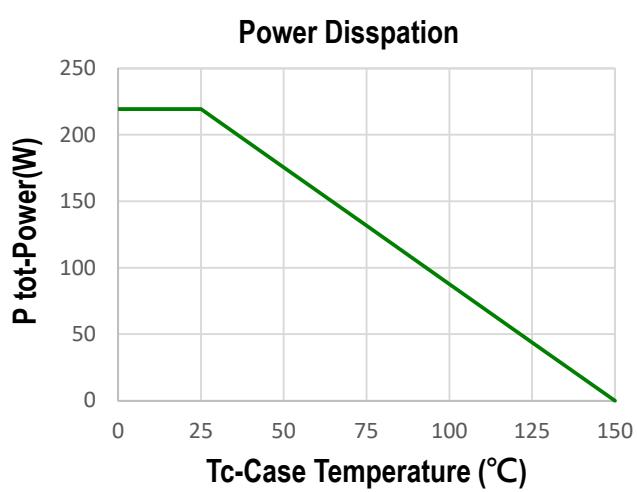
**Fig. 7: Typical Capacitance Variation Vs V<sub>DS</sub>**



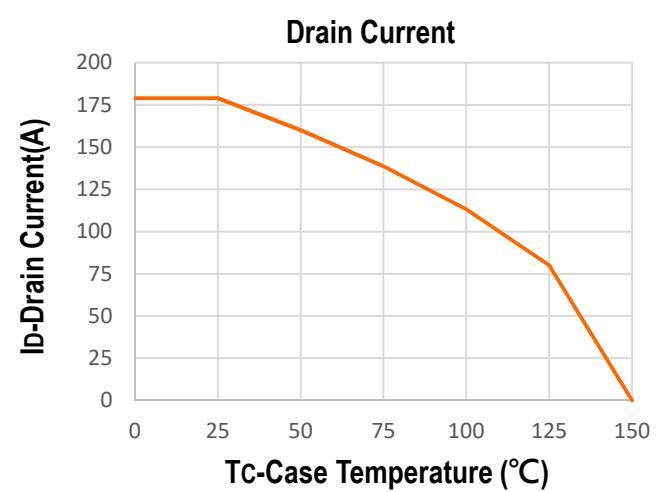
**Fig. 8: Gate Charge Vs V<sub>GS</sub>**



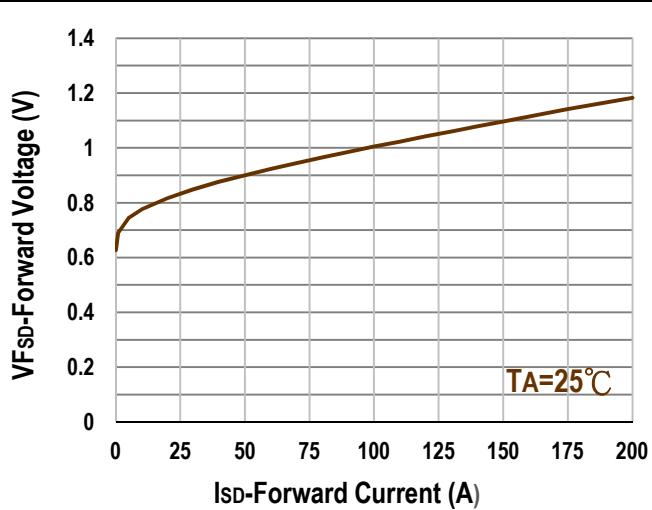
**Fig. 9: Power Dissipation Vs. T<sub>c</sub>**



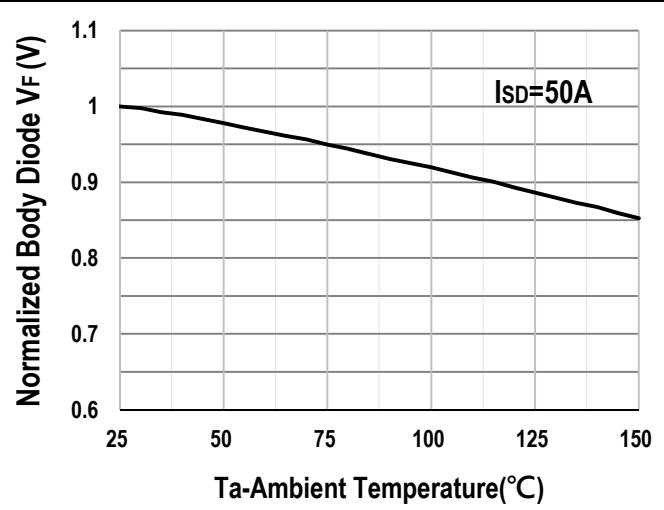
**Fig. 10: Drain Current Vs. T<sub>c</sub>**



**Fig. 11: Body Diode Forward Voltage Vs. I<sub>s</sub>**

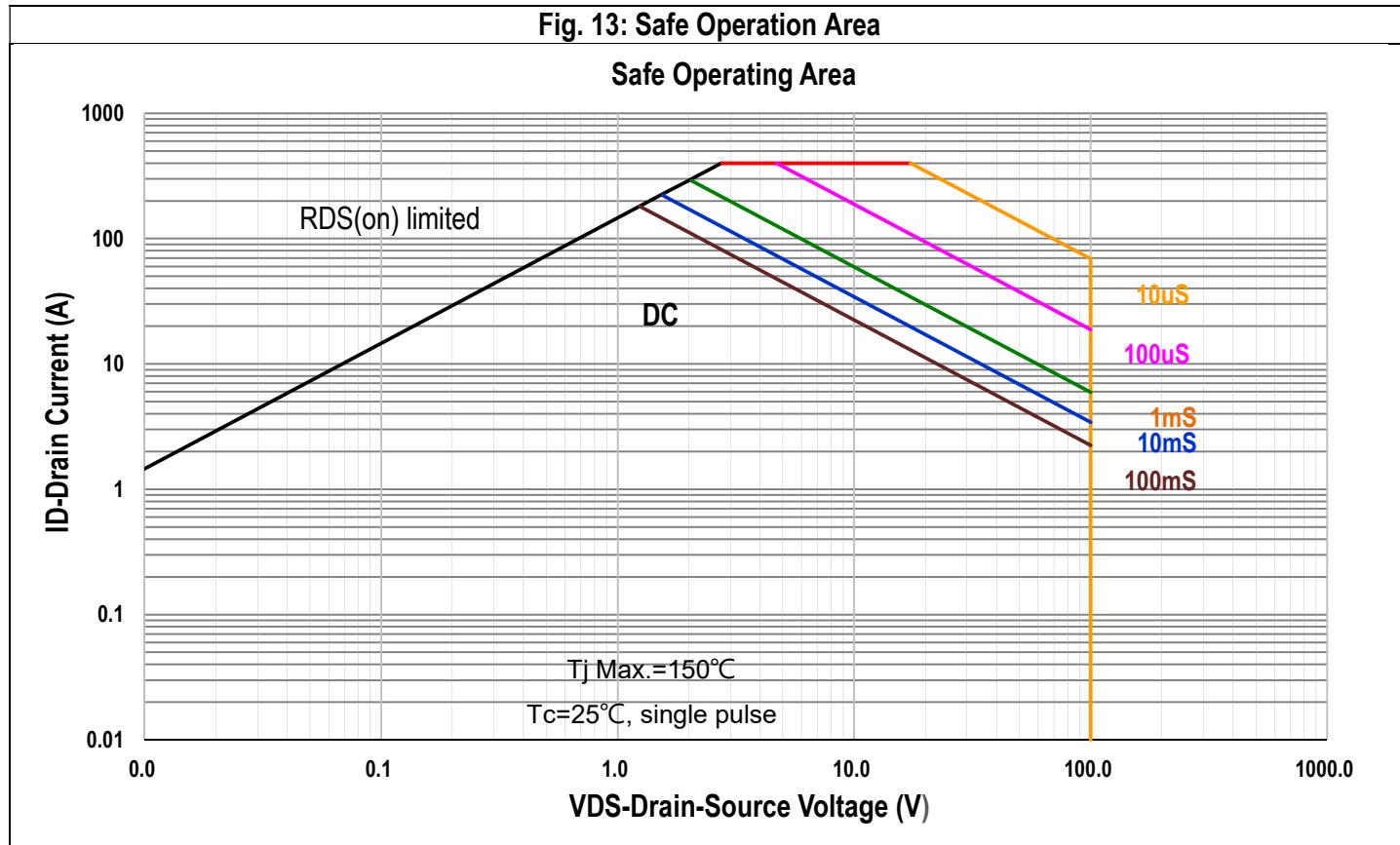


**Fig. 12: Normalized Body Diode Forward Voltage Vs. T<sub>a</sub>**

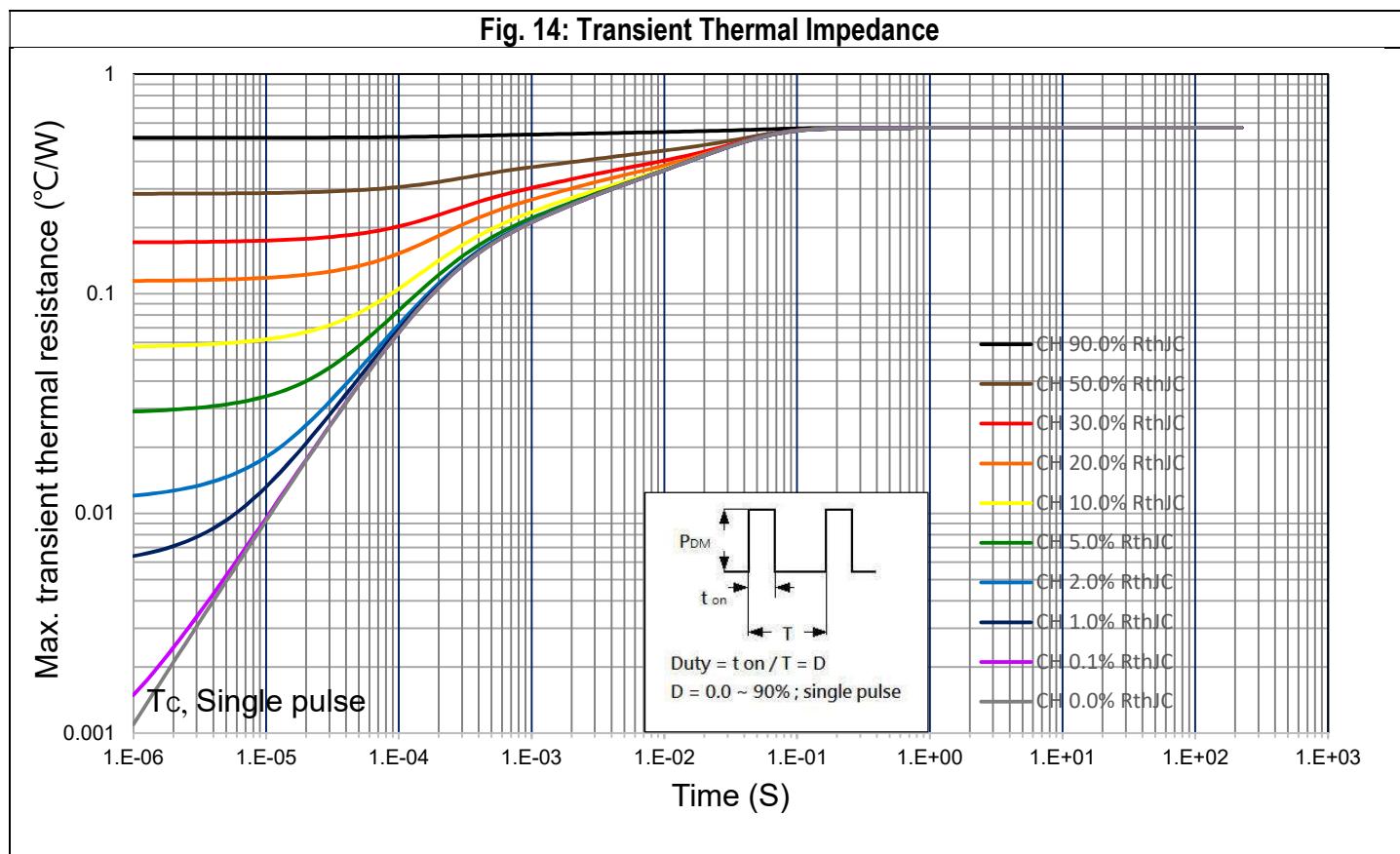


#### 4. Typical Operating Characteristics Diagram

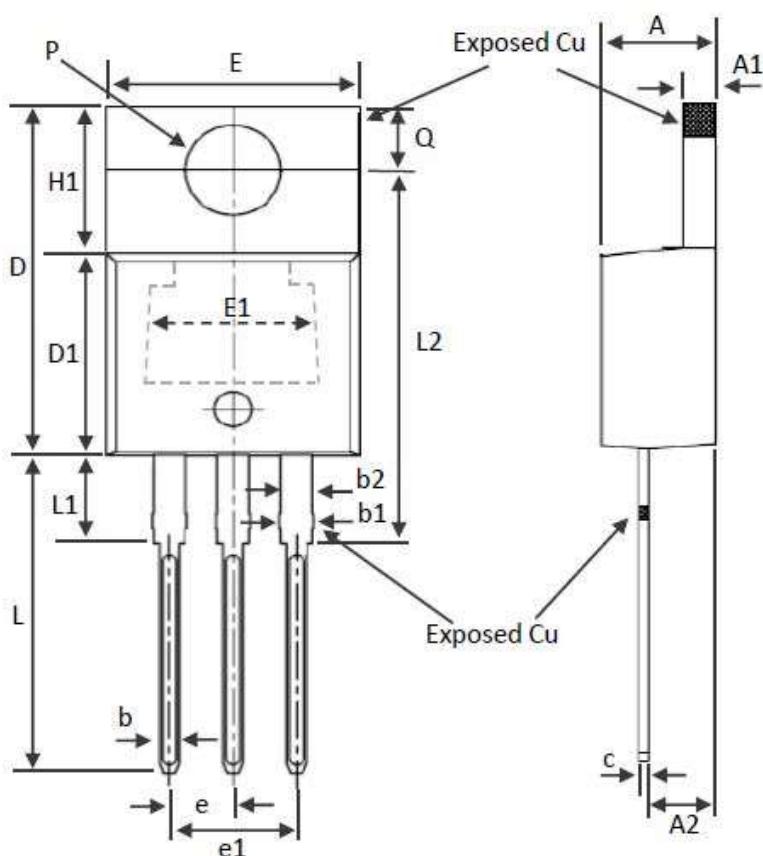
**Fig. 13: Safe Operation Area**



**Fig. 14: Transient Thermal Impedance**



## 5. Package of Dimension



Symbol	Min	Nor	Max
A	3.56	4.57	4.82
A1	0.51	1.27	1.39
A2	2.04	2.67	2.92
b	0.39	0.81	1.01
b1	1.15	1.37	1.82
b2	1.15	1.27	1.77
D	14.22	15.00	16.51
D1	8.39	8.70	9.01
D2	11.45	11.94	12.87
E	9.66	10.11	10.66
E1	6.86	7.00	8.89
e		2.54 Ref.	
e1		5.08 Ref.	
H1	5.85	6.30	6.85
L	12.70	13.60	14.73
L1	-	3.75	6.35
L2	15.80	16.00	16.20
P	3.54	3.87	4.08
Q	2.54	2.74	3.42

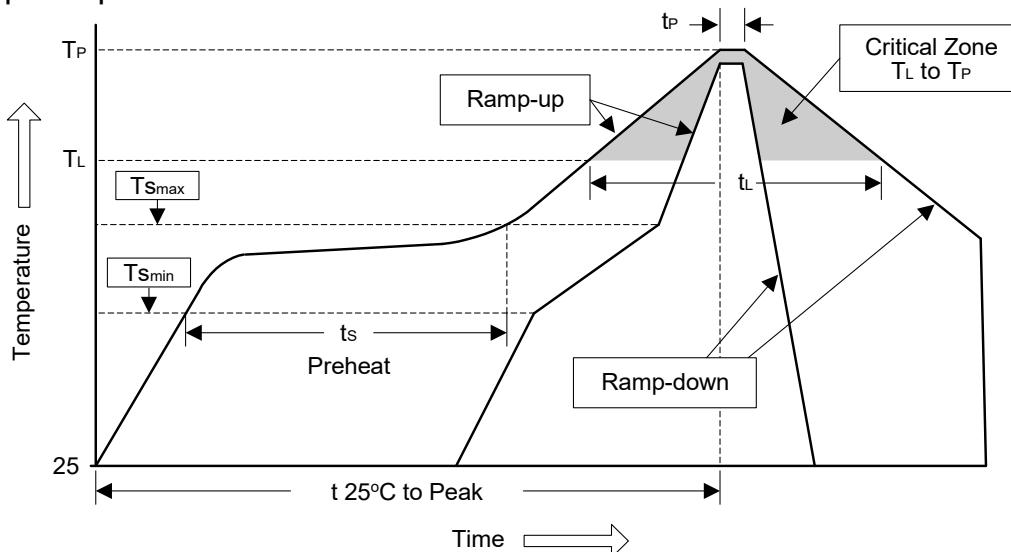
1. All dimension are in millimeters.
2. Dimension does not include burrs and mold flash/protrusions.

## 6. Appendix-A

### Soldering Methods for SiliconGear's Products (Just for SMD type of device)

1. Storage environment: Temperature=10°C to 35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices

**Figure 1: Temperature profile**



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate ( $T_L$ to $T_p$ )	$<3^{\circ}\text{C/sec}$	$<3^{\circ}\text{C/sec}$
Preheat		
- Temperature Min ( $T_{s\min}$ )	100°C	150°C
- Temperature Max ( $T_{s\max}$ )	150°C	200°C
- Time (min to max) ( $t_s$ )	60 to 120 sec	60 to 180 sec
$T_{s\max}$ to $T_L$	$<3^{\circ}\text{C/sec}$	$<3^{\circ}\text{C/sec}$
- Ramp-up Rate		
Time maintained above:		
- Temperature ( $T_L$ )	183°C	217°C
- Time ( $t_L$ )	60 to 150 sec	60 to 150 sec
Peak Temperature ( $T_p$ )	240°C $+0/-5^{\circ}\text{C}$	260°C $+0/-5^{\circ}\text{C}$
Time within 5°C of actual Peak Temperature ( $t_p$ )	10 to 30 sec	20 to 40 sec
Ramp-down Rate	$<6^{\circ}\text{C/sec}$	$<6^{\circ}\text{C/sec}$
Time 25°C to Peak Temperature	$<6$ minutes	$<8$ minutes

### 3. Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	$245^{\circ}\text{C} \pm 5^{\circ}\text{C}$	$5\text{sec} \pm 1\text{sec}$
Pb-Free devices.	$260^{\circ}\text{C} +0/-5^{\circ}\text{C}$	$5\text{sec} \pm 1\text{sec}$

**7. Appendix-B****Important Notice****© Silicongear Corporation**

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